

THE CELLER IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.

09/919,868

Applicant

Yen-Ting Lu

Filed

August 2, 2001

Title

METHOD FOR REDUCING LINE EDGE

ROUGHNESS OF PATTERNED PHOTORESIST

Examiner

YOUNG, CHRISTOPHER G

Docket No.

4425-168

Honorable Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

<u>AMENDMENT</u>

Sir:

In response to the Official Action mailed June 27, 2003, Applicant submits herewith an RCE and respectfully amends the application according to the Official Action.

Please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begin on page 2 of this paper.

Remarks/Arguments begin on page 9 of this paper.